

Search Notes



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Examiner

Hieu Phan

Applicant(s)/Patent under Reexamination

TSENG ET AL.

Art Unit

3738

SEARCHED

Class	Subclass	Date	Examiner
update	search	12/08/05	P

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR